Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/766,299	ZVEREV ET AL.	
Examiner	Art Unit	
Y. J. Han	2838	

	SEARCHED		
Class	Subclass	Date	Examiner
323	222		
	271		_
	272		
	276		
	277		
	284		
	285		
	286		
	288		
	901		
	908		
363	49		
	50	1/06	9#

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
PLUS	1/06	&A	